Applicant(s)/Patent Under Reexamination Application/Control No. 10/591,294 OHMI ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 LAN VINH 1792

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,265,268	11-1993	Tahim, Raghbir S.	455/328
*	В	US-5,188,862	02-1993	Itatani et al.	427/570
*	С	US-2004/0250954	12-2004	Choe et al.	156/345.47
*	D	US-6,184,624 j	02-2001	Inouchi, Yutaka	315/111.81
*	Е	US-6690702 2/2004	-03-2002 ·	Ishilletal: Ohmi etal.	219/121.36
	F	US-			
	G	US-			
	H	US-			
	٠ ١	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Φ					
	ø					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.